

RTC-700B

Environment Test Report

Report NO: 16R020002

| | |
|---------|---|
| Summary | <p><input checked="" type="checkbox"/> Pass</p> <p><input type="checkbox"/> Fail</p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> Pass with Deviation</p> <p>Comment: _____</p> |
|---------|---|

Issue date

2016-09-26

QE Manager

KJ Wang

Test Engineer

Ben Sun

Test Item List

| | |
|---|-----------|
| 1. Test Item List ----- | 2 |
| 2. Test Configuration ----- | 3 |
| 3. Temp./humidity power on/off test ----- | 4 |
| 4. Room Temperature Test ----- | 5 |
| 5. Temperature Rise Test ----- | 8 |
| 6. High Temperature Storage Test ----- | 11 |
| 7. High Temperature Operation Test ----- | 12 |
| 8. Low Temperature Storage Test ----- | 13 |
| 9. Low Temperature Operation Test ----- | 14 |
| 10. Humidity Test ----- | 15 |
| 11. Temperature Shock Operation Test ----- | 16 |
| 12. Temperature Shock Non-operation Test ----- | 17 |
| 13 Cold Start And Hot Start Test ----- | 18 |

Testing Result

| Num | Test item list | Result | Remark |
|-----|--------------------------------------|--------|--------|
| 1 | Temp./humidity power on/off test | Pass | |
| 2 | Room temperature test | Pass | |
| 3 | Temperature rise test | Pass | |
| 4 | High temperature storage test | Pass | |
| 5 | High temperature operation test | Pass | |
| 6 | Low temperature storage test | Pass | |
| 7 | Low temperature operation test | Pass | |
| 8 | Humidity test | Pass | |
| 9 | Temperature shock operation test | Pass | |
| 10 | Temperature shock non-operation test | Pass | |
| 11 | Cold start and hot start test | Pass | |

Configuration of EUT

| Test Product: RTC-700B | | |
|--|-------------------------|--|
| Sample Configuration & Quantity Under Test: | | |
| Num | Item | Description |
| RTC-700B | | |
| 01. | CPU: | Intel Atom x5-Z8350 Processor (2M Cache, up to 1.92 GHz) |
| 02. | PCBA | Rev: A1.0_0_0 |
| 03. | BIOS | R1.0 |
| 04. | Memory | NANYA NT5CC256M16DP-DI (2GB DDRL-1600) |
| 05. | Storage | Samsung KLMCG4JENB-B041 (eMMC 64GB) |
| 06. | 3G | QUECTEL UC20 Mini PCIe |
| 07. | WLAN + BT Module | AMPAK WL334(802.11abgn+BT4.0) |
| 08. | Battery | RTC600H, RTC600S (1530mAh x 2) |
| 09. | AC Adapter | FSP036-RBBN2 (12VDC/3A/36W) |
| 10. | Test Software | Windows 10 IOT Enterprise x64 Editoin |

Temp./humidity power on/off test

Test Date: 06-13~14 - 2016

Test Model: RTC-700B Main Board only

Test Site: AAEON QE Dept.

Test Standard: Refer to IEC 68-2-30 Testing procedures
 Test Db: Damp Heat Test
 Refer to IEC 68-2-1 Testing procedures
 Test Ab: Cold Test

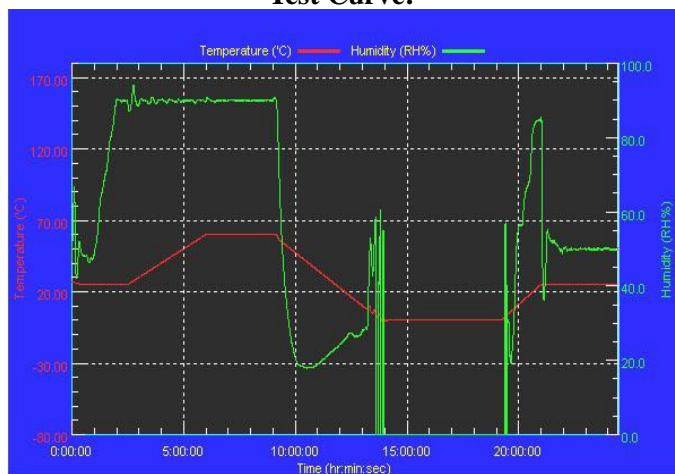
Test Equipment:
 Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
 Model: THS-B6T-150+LN2
 Date of Calibration: 04/26/16
 Serial Number: 6488KT

Temperature & Humidity Power On/Off Test:

Testing Specification:

| Step | Temperature (°C) | Humidity (%RH) | Duration (HH:MM) |
|------|------------------|----------------|------------------|
| 1 | 25 | 50 | 00:30 |
| 2 | 25 | 50 | 00:30 |
| 3 | 25 | 90 | 01:00 |
| 4 | 25 | 90 | 00:30 |
| 5 | 60 | 90 | 03:30 |
| 6 | 60 | 90 | 03:00 |
| 7 | 0 | 0 | 04:50 |
| 8 | 0 | 0 | 05:23 |
| 9 | 25 | 50 | 01:47 |
| 10 | 25 | 50 | 03:00 |

Test Curve:



Test Result:

No issues were found during the temperature & humidity power on/off test.

| Test Method | Actual | Successful | Failure rate |
|-----------------------------------|------------|------------|--------------|
| Power On/Off | 1279/times | 1279/times | 0 % |
| Note: Failure rate need to be 0%. | | | |

Room Temperature test

Test Date: 06-02~03-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

Temperature Measurement:

40 Channel Thermal Recorder:
YOKOGAWA Inc,
Model: DA100-13-1D
Date of Calibration: 09/10/15
Serial Number: 12A323190

Test Condition:

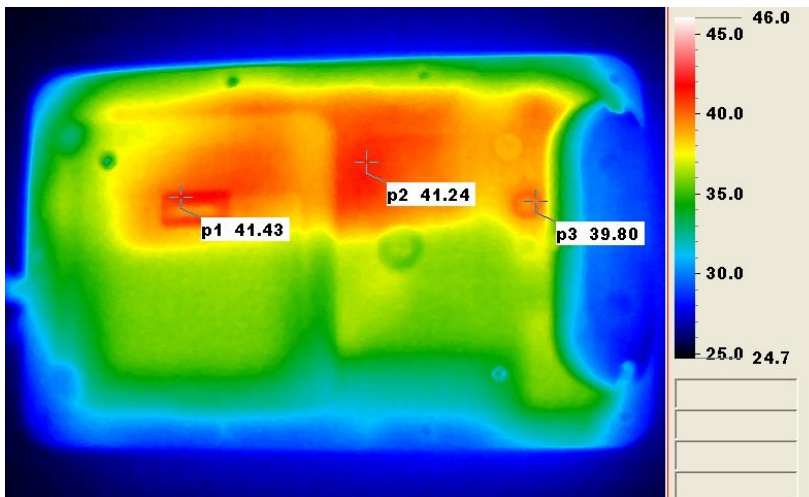
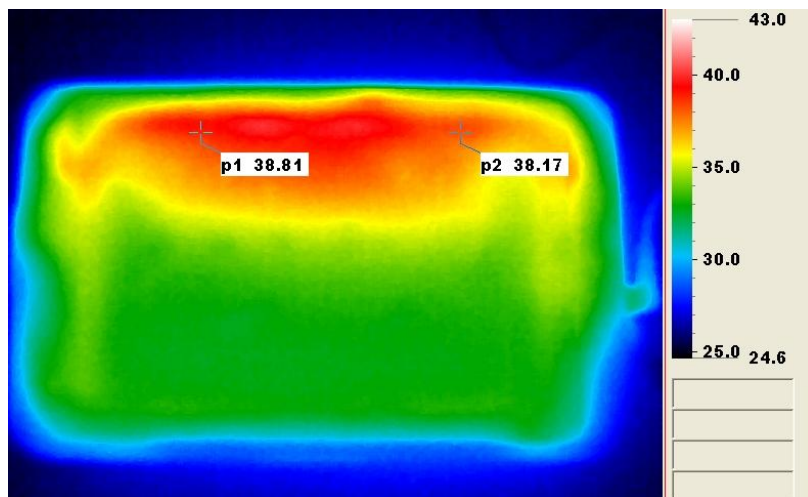
Ambient temperature: 25°C
Continuous running till temperature stable (within less than 1°C)

Test Software:

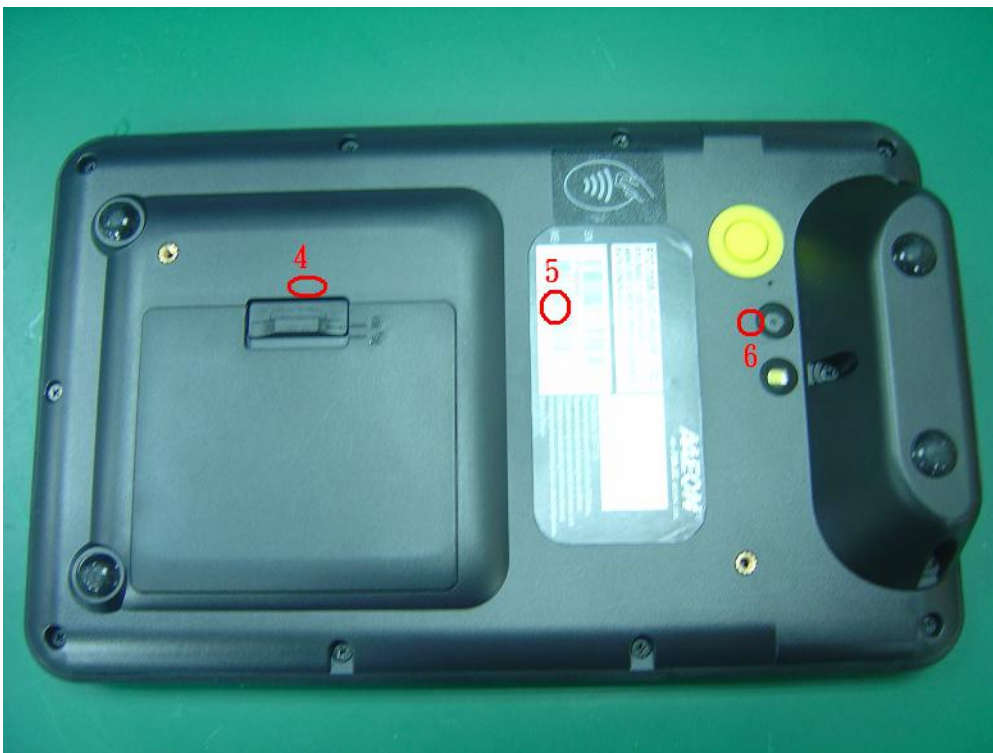
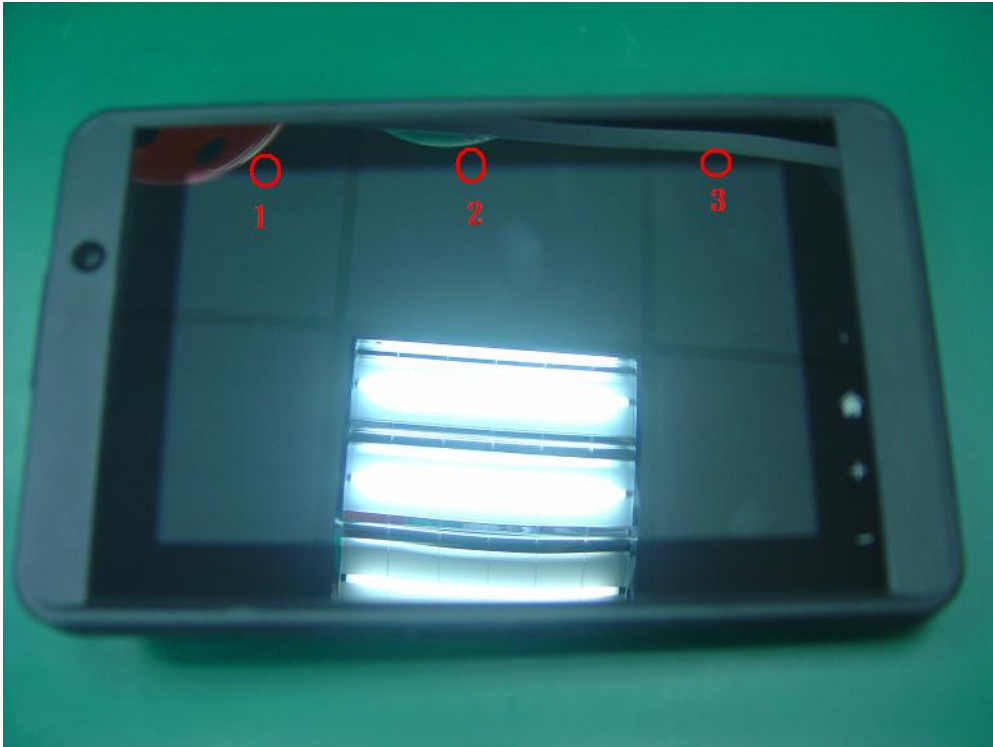
Windows 10 / Run Burn-in Test 8.1 Pro

Terminal Recorder:

Measuring Thermal Couple Position :



Room Temperature test



Thermal profile data:**RTC-700B**

| Point | Temp. Stage(°C) | Spec | Tm |
|------------------|-----------------|------|------|
| 1. Point 1 | | 50°C | 45.7 |
| 2. Point 2 | | | 45.6 |
| 3. Point 3 | | | 43.5 |
| 4. Point 4 | | | 45.5 |
| 5. Point 5 | | | 44.2 |
| 6. Point 6 | | | 44.3 |
| Room Temperature | | | 25.0 |

Any Tm value showed in **red words** means the value over the Tc degree C of this device specification.

Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found during the room temperature operation test.

Temperature rise test

Test Date: 06-03~07-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

Test Standard: Refer to EN 61131-2(94), UL508 (94)

Temperature Measurement:

40 Channel Thermal Recorder:

YOKOGAWA Inc,

Model: DA100-13-1D

Date of Calibration: 09/10/15

Serial Number: 12A323190

Test Condition:

Ambient temperature: 35°C

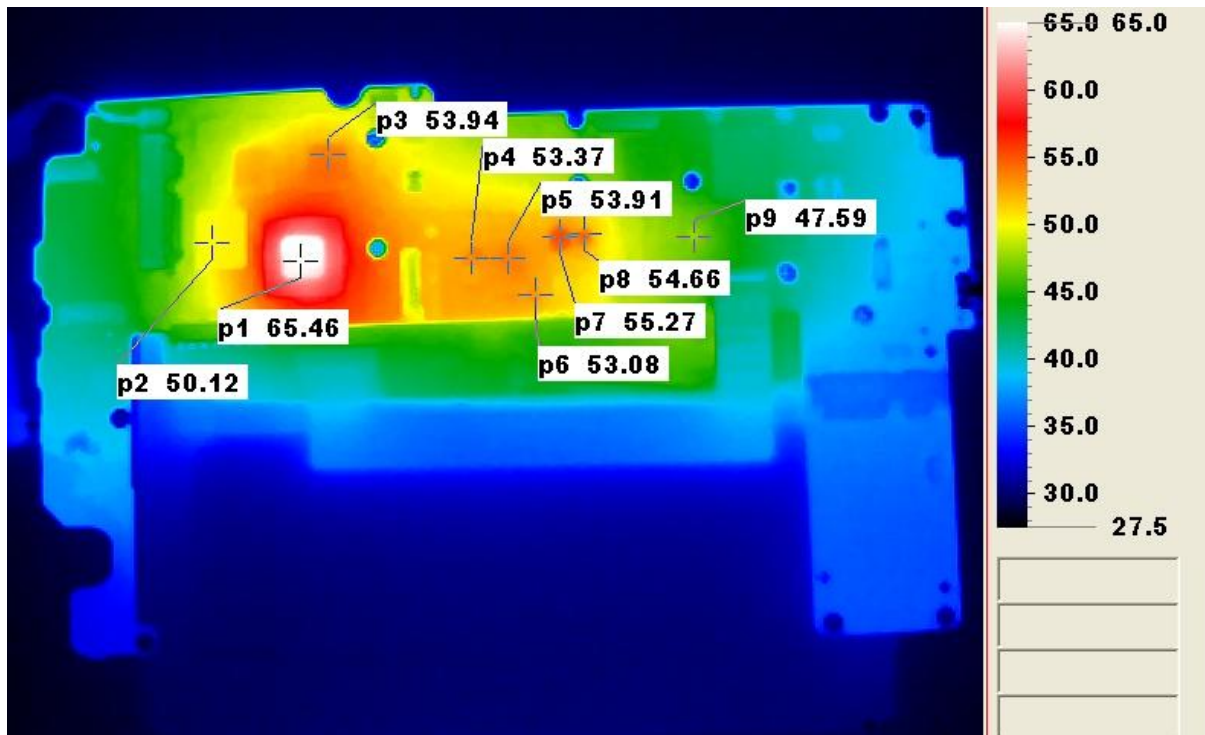
Continuous running till thermal stability (within less than 1°C)

Test Software:

Windows 10 / Run Burn-in Test 8.1 Pro

Terminal Recorder:

Measuring Thermal Couple Position :



Thermal profile data:

RTC-700B

| Point | Position | Describe | Tc (*1) (°C) | Tm (*2) Measured Under | Note |
|-------|----------|--|-----------------|---------------------------|-------|
| | | | | 35.0°C | |
| 1 | U1 | (TF)INTEL CPU.SOC.Cherry Trail-T3 x5-Z8350.1.92GHz UTFCBGA.592P.FJ8066401836620 SR2KT | 90 | 89.3 | NOTE4 |
| 2 | U16 | (TF)IC.eMMC 5.1 MLC Flash.64GB FBGA 153P.SMD SAMSUNG KLMCG4JENB-B041 | 100 | 77.3 | |
| 3 | U10 | (TF)IC.4G.DDR3L-1600.SDRAM.1.35V.256Mbit*16.8n.FBGA 96ball.SMD.NANYA.NT5CC256M16DP-DI | 110 | 82.2 | |
| 4 | L9 | (TF)COIL.1.5uH.2.8A.72mohm.20%.SMD.2.5x2.0x1.2mm.Zenith Tek.ZADP-252012MES-1R5M | 125 | 83.0 | |
| 5 | U69 | (TF)IC.PMIC for Intel Cherry Trail.CR Platform VQFN 64P 8x8mm SMD.TI.SND9039A2CTRSKR | 100 | 84.7 | |
| 6 | L12 | (TF)COIL.1.5uH.2.8A.72mohm.20%.SMD.2.5x2.0x1.2mm.Zenith Tek.ZADP-252012MES-1R5M | 125 | 82.3 | |
| 7 | L14 | (TF)COIL.2.2uH.DCR=52mohm.Idc=3Amp.20%.SMD.4.45*4.05* 2.0mm.Zenithtek.ZPWM-4020M-2R2M | 125 | 81.0 | |
| 8 | U72 | (TF)IC.Step-Down Converter 2.5MHz QFN-16 SMD.TI.TPS62130RGT | 100 | 86.6 | |
| 9 | U78 | (TF)IC.Display Port to LVDS Converter.QFN 48P SMD Realtek RTD2136N-CGT | 85 | 67.9 | |

Note(*):

1. "Tc" indicates the component's case maximum temperature value specified in its datasheet.
2. "TAT" indicates the actual measured temperature in chamber.
3. "TPT" indicates the predicted temperature by offset from TAT

4. Judgment Criteria:

- **Fail** : Tm > Tc; The measured value is over specification.
- **Margin Pass** : Tc > Tm > Tc-5°C; The measured value is within specification with margin.
It is strongly recommended to add thermal dissipation design for better reliability.
- **Pass** : Tm < Tc-5°C; The measured value is with safety margin.

5. Defect NO.

Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found during the temperature rise operation test.

High temperature storage test

Test Date: 05-16 ~ 22-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

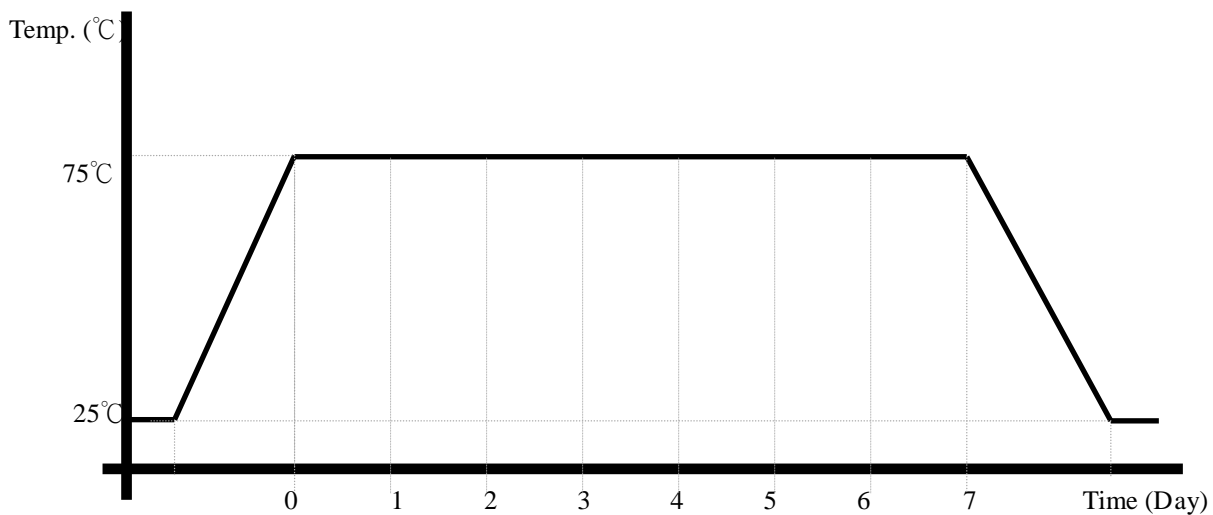
Test Standard: Refer to MIL-STD 810G Method 501.5 High Temperature
Procedure I - Storage

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Testing Item:

1. Test Temperature: 75°C
2. Test Time: 7days
3. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found after the high temperature storage test.

High temperature operation test

Test Date: 05-23 ~ 27-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

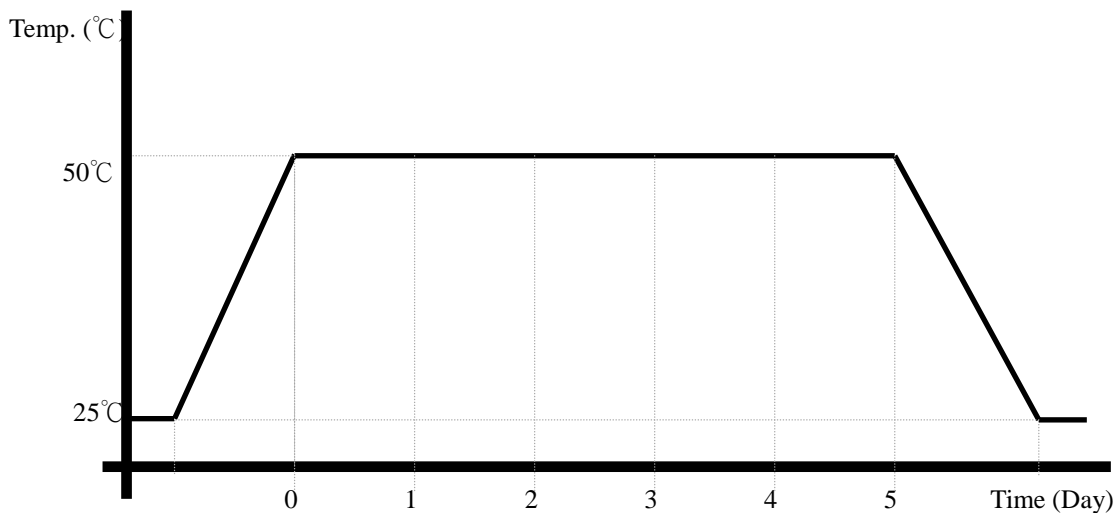
Test Standard: Refer to MIL-STD 810G Method 501.5 High Temperature
Procedure II - Operation

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Testing Item:

1. Test Temperature: 50°C
2. Test Time: 5days
3. Test Software: Windows 10 / Run Burn-in Test 8.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found during the high temperature operation test.

Low temperature storage test

Test Date: 05-30~31-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

Test Standard: Refer to MIL-STD 810G Method 502.5 Low Temperature
Procedure I - Storage

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)

Model: THS-B6T-150+LN2

Date of Calibration: 04/26/16

Serial Number: 6488KT

Testing Item:

1. Test Temperature: -55°C
2. Test Times: 24Hrs
3. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found after the low temperature storage test.

Low temperature operation test

Test Date: 07-04~06-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

Test Standard: Refer to MIL-STD 810G Method 502.5 High Temperature
Procedure II - Operation

Test Equipment:

Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)

Model: THS-B6T-150+LN2

Date of Calibration: 04/26/16

Serial Number: 6488KT

Testing Item:

1. Test Temperature: -23°C
2. Test Times: 24Hrs
3. Test Software: Windows 10 / Run Burn-in Test 8.1 Pro
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found during the low temperature operation test.

Humidity test

Test Date: 05-09~11-2016

Test Product: RTC-700B

Test Site: AAEON QE Dept.

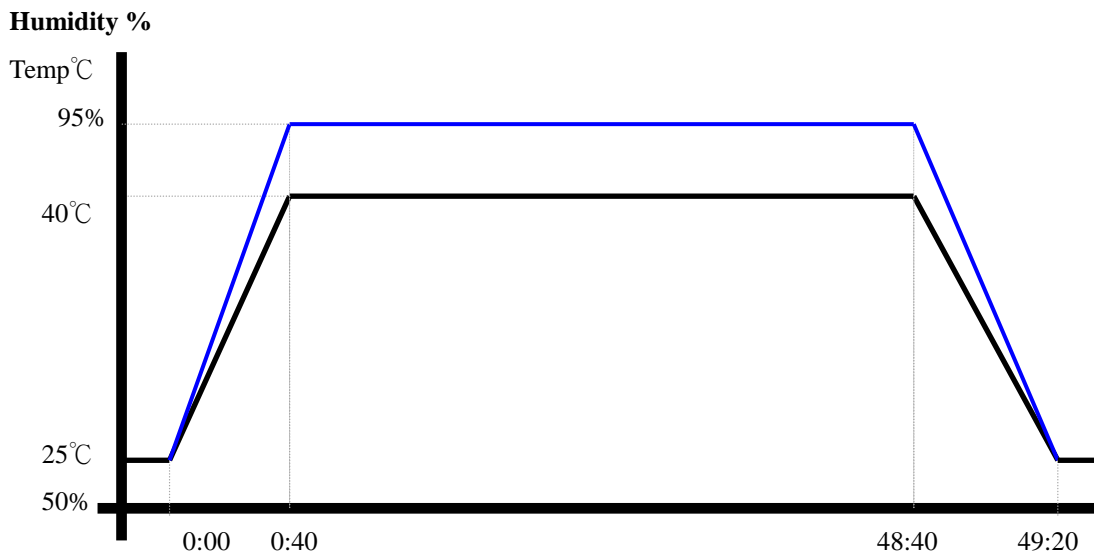
Test Standard: Refer to IEC 68-2-3 Testing procedures
Test Ca: Damp heat, steady state (Non-operation)

Test Equipment:

Programmable Temperature & Humidity Chamber: (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Testing Item:

1. Test Temperature: 40°C
2. Test Humidity: 95% RH
3. Test Times: 48Hrs
4. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issue was found after the humidity storage test.

Temperature shock operation test

Test Date: 09-19~21-2016

Test Product: RTC-700B

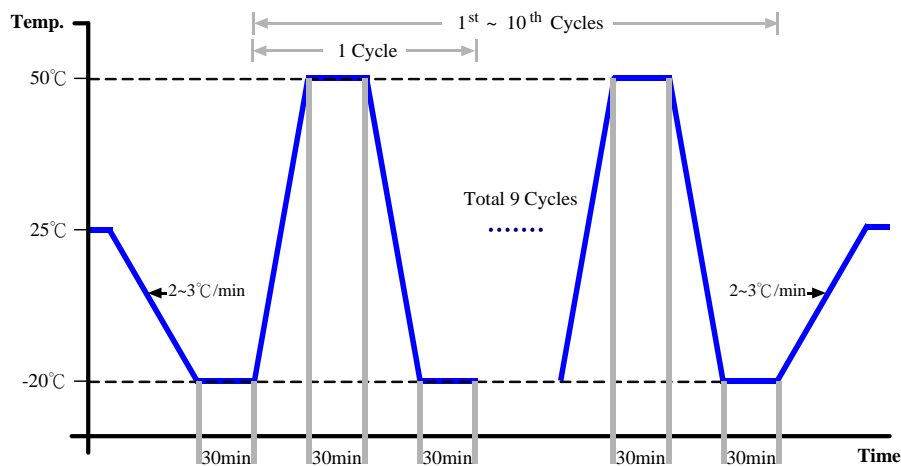
Test Site: AAEON QE Dept.

Test Standard: Refer to MIL-STD 810G Method 503.5 Temperature Shock
Procedure I - Shock from constant extreme temperatures

Test Equipment:
Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Test Condition:

1. Test Low Temperature: -20°C
2. Test High Temperature: 50°C
3. Test dwell time: 30min
4. Temperature slope: 5 min
5. Test cycle: 10 cycles
6. Test Software: Windows 10 / Run Burn-in Test 8.1 Pro
7. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found during the variation temperature operation test.

Temperature shock non-operation test

Test Date: 06-14~15-2016

Test Product: RTC-700B

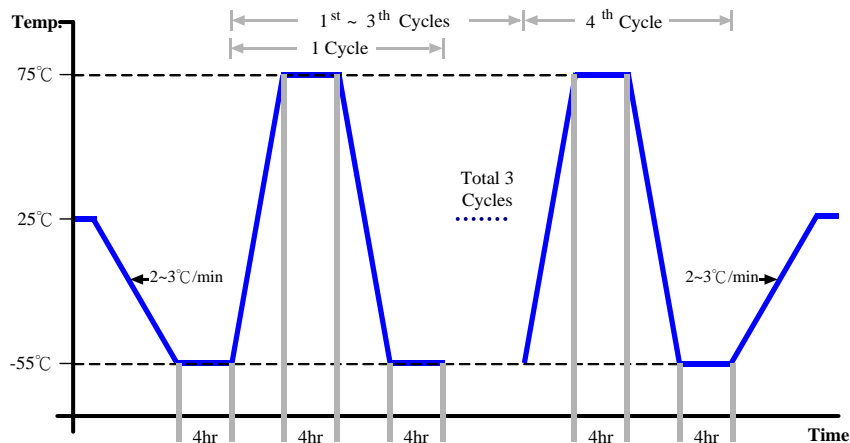
Test Site: AAEON QE Dept.

Test Standard: Refer to MIL-STD 810G Method 503.5 Temperature Shock
Procedure I - Shock from constant extreme temperatures

Test Equipment:
Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP.)
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Test Condition:

1. Test Low Temperature: -55°C
2. Test High Temperature: 75°C
3. Test dwell time: 4Hrs
4. Temperature slope: 10 min
5. Test cycle: 4 cycles
6. Test Environment Curve:



Sample Configuration & Quantity Under Test:

Quantity: 1 (RTC-700B)

Test Result:

No issues were found after the variation temperature non-operation test.

Cold start and hot start test

Test Date: 06-07~08-2016

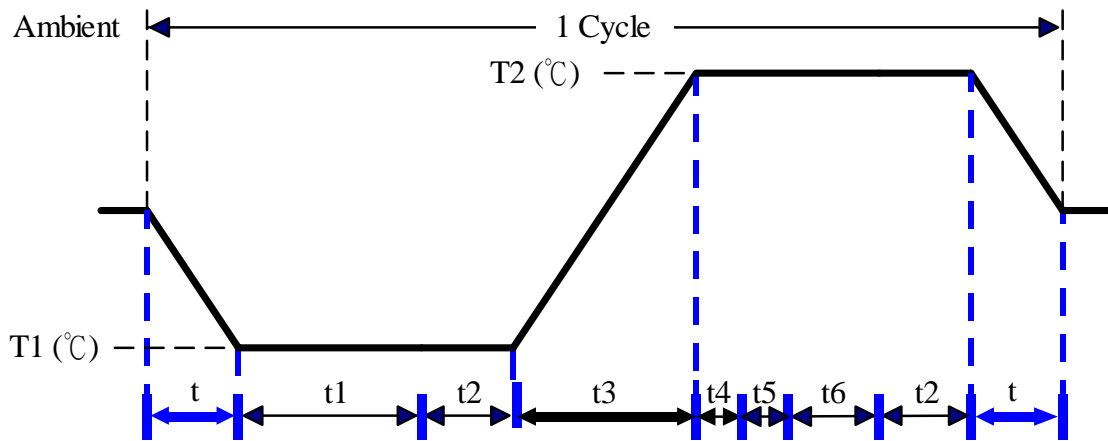
Test Product: RTC-700B

Test Site: AAEON QE Dept.

Test Standard: Refer to IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber (K.SON. INS. TECH. CORP).
Model: THS-B6T-150+LN2
Date of Calibration: 04/26/16
Serial Number: 6488KT

Test Condition:



| Parameters | Description |
|------------|-------------|
| T1 | -20°C |
| T2 | 50°C |
| t1 | 4 hrs |
| t2, t6 | 2 hrs |
| t4, t5 | 1hrs |
| t, t3 | 2°C/min |
| n (Cycle) | 1 |

t = temprature slope
t , t1, t6: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3, t4: Run Burn in Test
t5: Windows OS restart test 3 times
Test Software:Windows 10

Test Result:

- a. No issues were found during the cold start test.
- b. No issues were found during the hot start test.